	Search Notes					
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Application/Control No.	Applicant(s)/Patent under Reexamination
10/645,540	TACHINO, ATSUSHI
Examiner	Art Unit
Ja-Na Hines	1645

SEARCHED				
Class	Subclass	Date	Examiner	
424	78.11, 165.1, 537	9/15/2005	JAH	
426	534			
252	183.13			
435	41, 144			
436	174			
514	772.1			
524	381			
562	585			

TNI	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	

(INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
STIC, West, scisearch, registry, biosis, medline, argicola, biotechno, caplus, wpids, japio, JPI, eplus,	9/15/2005	JAH			
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